Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
09/843,197	CHIU ET AL.
Examiner	Art Unit

2178

Cong-Lac Huynh

SEARCHED					
Class	Subclass	Date	Examiner		
715	500	4/6/2007	CLH		
	500.1	4/6/2007	CLH		
	530	4/6/2007	CLH		
	531	4/6/2007	CLH		
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INT	INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner			
715	500	6/7/1944	CLH			
	500.1	4/6/2007	CLH			
			,			
	Interference Search History Printout		CLH			

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
East (USPAT, USPGPUB. JPO, EPO, Derwent	4/6/2007	CLH
Google	4/6/2007	CLH
АСМ	4/6/2007	CLH
IEEE	4/6/2007	CLH